

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination GONZALEZ ET AL.	
		Examiner LUU MATTHEW	Art Unit 3663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0130870	09-2002	Ebihara, Hitoshi	345/440
*	B	US-2004/0223003	11-2004	Heirich et al.	345/629
*	C	US-2004/0085322	05-2004	Alcorn et al.	345/562
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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